Notice of References Cited Application/Control No. 10/573,848 Examiner RIP A. LEE Applicant(s)/Patent Under Reexamination STOLL ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | Α | US-6,824,865 | 11-2004 | Funaoka et al. | 428/315.5 |
| * | В | US-6,842,103 | 01-2005 | Yoshinari et al. | 338/22R |
| | U | US- | | | |
| | D | US- | | | |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Ι | US- | | | |
| | - | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | ┙ | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------------|----------------|----------------|
| | Ν | WO 00/20492 A1 | 04-2000 | International | Funaoka et al. | C08J 9/28 |
| | 0 | | | | | |
| | Ρ | | | | | |
| | σ | | | | | |
| | R | | | | | |
| | Ø | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | ٧ | |
| | W | |
| | × | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.